

# Search Notes



Application/Control No.

10/090,090

Examiner

Michael Pak

Applicant(s)/Patent under Reexamination

CHEN, FANG

Art Unit

1646

## SEARCHED

Class	Subclass	Date	Examiner
<del>435</del>	<del>325</del>	<del>3-29-05</del>	<del>MDP</del>
536	23.5	3-29-05	MDP
435	69.1		
435	320.1		
435	325		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
BES search	3-29-05	MDP
STIC SEQ SEARCH paint application 09/20/09, 069 attached	3-29-05	MDP